



Joseph S. Iandiorio
Mark Teska
Jason D. Shanske
Thomas E. Thompson, Jr.
Roy J. Coleman
R. Stephen Rosenholm
David W. Poirier

IANDIORIO & TESKA

INTELLECTUAL PROPERTY LAW ATTORNEYS

260 BEAR HILL ROAD
WALTHAM, MASSACHUSETTS 02451

RECEIVED

OCT 21 2002

100800 MAIL ROOM

Tel: (781) 890-5678
Fax: (781) 890-1150
e-mail: admin@iandiorio.com
web: www.iandiorio.com

October 9, 2002

Box RCE
Commissioner for Patents
Washington, DC 20231

SUBJECT: Applicant: Cunningham *et al.*
 Serial No: 09/543,612
 Filed: April 5, 2000
 For: APPARATUS AND METHOD FOR MEASURING THE
 MASS OF A SUBSTRATE
 Group: 2856
 Examiner: Chapman, Jr., J.
 Docket No: DR-308J

Dear Sir:

In the Request For Continued Examination filed on October 8, 2002, the marked up version of the amendment to claim 23 was inadvertently omitted. Enclosed please find a copy of the marked up version of the amendment to claim 23.

If any payment during prosecution is found to be incorrect, please charge any deficiency or credit any overpayment to my Deposit Account No. 09-0002. A copy of this letter is enclosed for use by the Finance Branch in the event that it is necessary to make any charge or credit to my deposit account.

In addition, pursuant to Rule 1.136(a)(3), the Office is hereby authorized to treat any future reply requiring an extension of time as incorporating a request therefor. Also, any request or Petition for an Extension of Time notwithstanding an inadvertent reference in the Petition to a shorter period of time is to be treated as requesting the appropriate length of time.

Kindly acknowledge receipt of the foregoing by returning the enclosed self-addressed postcard.

Sincerely,

Roy J. Coleman
Reg. No. 48,863

RJC/mgt
Enclosures

CERTIFICATE OF MAILING

I hereby certify that the attached correspondence is being deposited with the United States Postal Service as first-class mail in an envelope addressed to: Box RCE, Commissioner of Patents, Washington, DC 20231, on October 9, 2002.

Marianne G. Tarczal



Marked up claim

23. (Twice amended) The apparatus of claim 1 in which the mass determining device measures [the change in mass of a substance within the subnanogram range] the mass of a substance in the range of about 100 picogram/mm² to 100,000 picogram/mm².